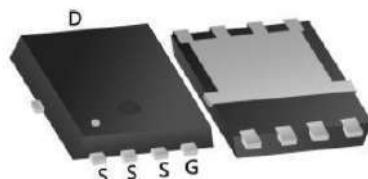


P-Ch 100V Fast Switching MOSFETs

Features:

- Advanced Trench MOS Technology
- Low Gate Charge
- 100% EAS Guaranteed
- Green Device Available

PRPAK3x3 Pin Configuration

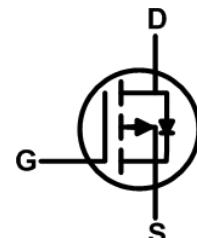


Applications:

- Power Management.
- DC Motor Control.

Product Summary

BVDSS	RDS(on)	ID
-100V	210mΩ	-6.3A



Absolute Maximum Ratings

Symbol	Parameter	Rating	Units
V _{DS}	Drain-Source Voltage	-100	V
V _{GS}	Gate-Source Voltage	±20	V
I _D @T _C =25°C	Continuous Drain Current, V _{GS} @ -10V ¹	-6.3	A
I _D @T _C =100°C	Continuous Drain Current, V _{GS} @ -10V ¹	-5.0	A
I _D @T _A =25°C	Continuous Drain Current, V _{GS} @ -10V ¹	-1.9	A
I _D @T _A =70°C	Continuous Drain Current, V _{GS} @ -10V ¹	-1.5	A
I _{DM}	Pulsed Drain Current ²	-25	A
EAS	Single Pulse Avalanche Energy ³	49	mJ
I _{AS}	Avalanche Current	-14	A
P _D @T _C =25°C	Total Power Dissipation ⁴	17.8	W
P _D @T _A =25°C	Total Power Dissipation ⁴	1.67	W
T _{STG}	Storage Temperature Range	-55 to 150	°C
T _J	Operating Junction Temperature Range	-55 to 150	°C

Thermal Data

Symbol	Parameter	Typ.	Max.	Unit
R _{θJA}	Thermal Resistance Junction-Ambient ¹	---	75	°C/W
R _{θJC}	Thermal Resistance Junction-Case ¹	---	7	°C/W

Electrical Characteristics ($T_J=25^{\circ}\text{C}$, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
BV_{DSS}	Drain-Source Breakdown Voltage	$\text{V}_{\text{GS}}=0\text{V}$, $\text{I}_D=-250\mu\text{A}$	-100	---	---	V
$\text{R}_{\text{DS(ON)}}$	Static Drain-Source On-Resistance ²	$\text{V}_{\text{GS}}=-10\text{V}$, $\text{I}_D=-2\text{A}$	---	---	210	$\text{m}\Omega$
		$\text{V}_{\text{GS}}=-4.5\text{V}$, $\text{I}_D=-1.6\text{A}$	---	---	240	
$\text{V}_{\text{GS(th)}}$	Gate Threshold Voltage	$\text{V}_{\text{GS}}=\text{V}_{\text{DS}}$, $\text{I}_D=-250\mu\text{A}$	-1.2	---	-2.5	V
I_{DSS}	Drain-Source Leakage Current	$\text{V}_{\text{DS}}=-80\text{V}$, $\text{V}_{\text{GS}}=0\text{V}$, $\text{T}_J=25^{\circ}\text{C}$	---	---	-1	uA
		$\text{V}_{\text{DS}}=-80\text{V}$, $\text{V}_{\text{GS}}=0\text{V}$, $\text{T}_J=85^{\circ}\text{C}$	---	---	-30	
I_{GSS}	Gate-Source Leakage Current	$\text{V}_{\text{GS}}=\pm 20\text{V}$, $\text{V}_{\text{DS}}=0\text{V}$	---	---	± 100	nA
R_g	Gate Resistance	$\text{V}_{\text{DS}}=0\text{V}$, $\text{V}_{\text{GS}}=0\text{V}$, $f=1\text{MHz}$	---	13	---	Ω
Q_g	Total Gate Charge (-10V)	$\text{V}_{\text{DS}}=-50\text{V}$, $\text{V}_{\text{GS}}=-10\text{V}$, $\text{I}_D=-2\text{A}$	---	19	---	nC
Q_{gs}	Gate-Source Charge		---	3.4	---	
Q_{gd}	Gate-Drain Charge		---	2.9	---	
$\text{T}_{\text{d(on)}}$	Turn-On Delay Time	$\text{V}_{\text{DD}}=-30\text{V}$, $\text{V}_{\text{GS}}=-10\text{V}$, $\text{R}_G=3.3\Omega$, $\text{I}_D=-1\text{A}$	---	9	---	ns
T_r	Rise Time		---	6	---	
$\text{T}_{\text{d(off)}}$	Turn-Off Delay Time		---	39	---	
T_f	Fall Time		---	33	---	
C_{iss}	Input Capacitance	$\text{V}_{\text{DS}}=-30\text{V}$, $\text{V}_{\text{GS}}=0\text{V}$, $f=1\text{MHz}$	---	1228	---	pF
C_{oss}	Output Capacitance		---	41	---	
C_{rss}	Reverse Transfer Capacitance		---	29	---	

Diode Characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
I_s	Continuous Source Current ^{1,5}	$\text{V}_G=\text{V}_D=0\text{V}$, Force Current	---	---	-6.3	A
V_{SD}	Diode Forward Voltage ²	$\text{V}_{\text{GS}}=0\text{V}$, $\text{I}_s=-1\text{A}$, $\text{T}_J=25^{\circ}\text{C}$	---	---	-1.2	V

Note :

1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
2. The data tested by pulsed , pulse width $\leq 300\text{us}$, duty cycle $\leq 2\%$
3. The EAS data shows Max. rating . The test condition is $\text{V}_{\text{DD}}=-25\text{V}$, $\text{V}_{\text{GS}}=-10\text{V}$, $\text{L}=0.5\text{mH}$, $\text{I}_{\text{AS}}=-14\text{A}$
4. The power dissipation is limited by 150°C junction temperature
5. The data is theoretically the same as I_D and I_{DM} , in real applications , should be limited by total power dissipation.

Typical Characteristics

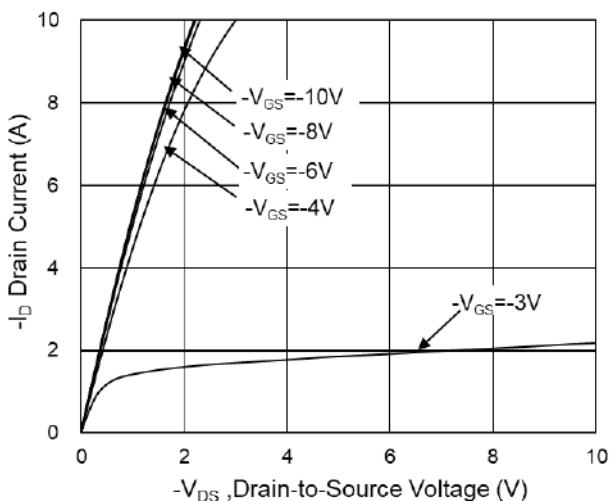


Fig.1 Typical Output Characteristics

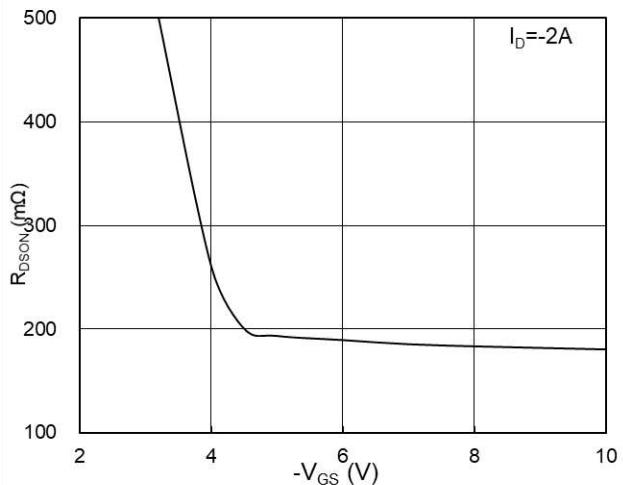


Fig.2 On-Resistance vs G-S Voltage

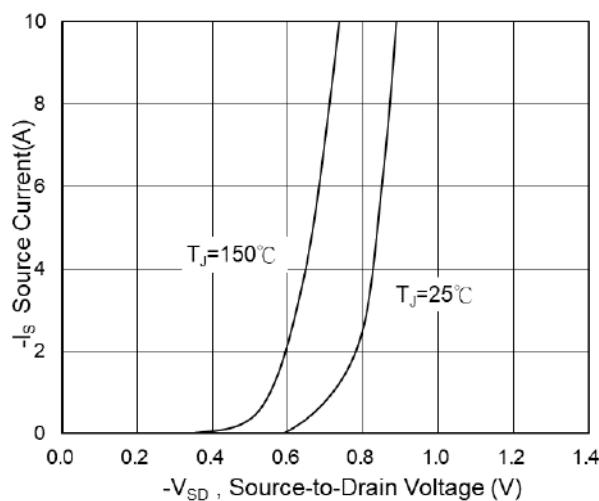


Fig.3 Source Drain Forward Characteristics

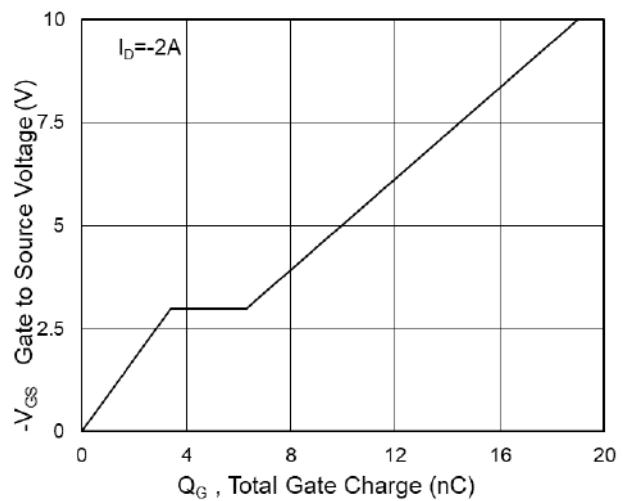


Fig.4 Gate-Charge Characteristics

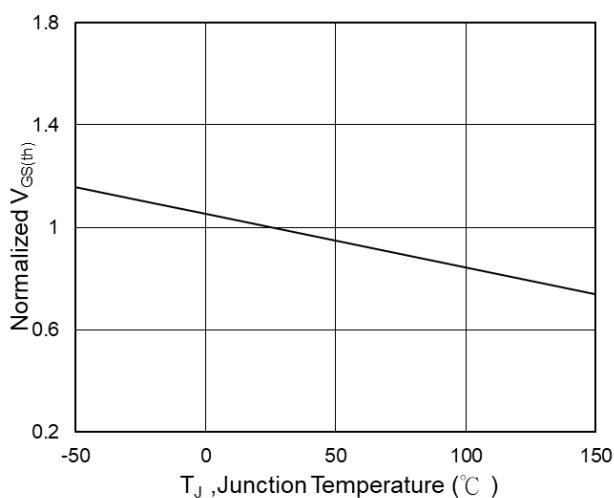


Fig.5 Normalized $V_{GS(\text{th})}$ vs T_J

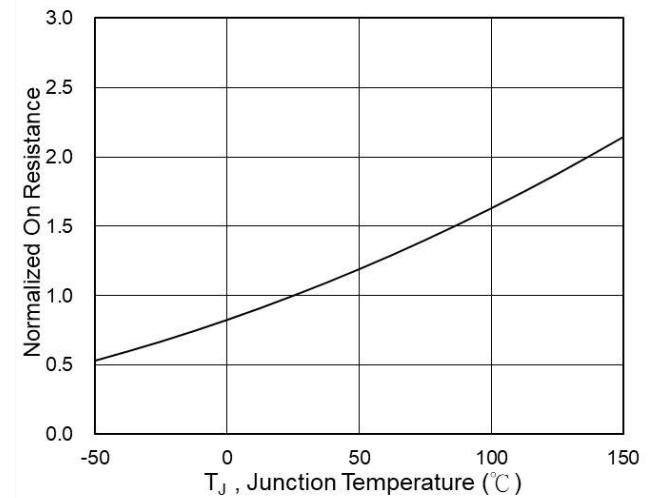


Fig.6 Normalized $R_{DS(on)}$ vs T_J

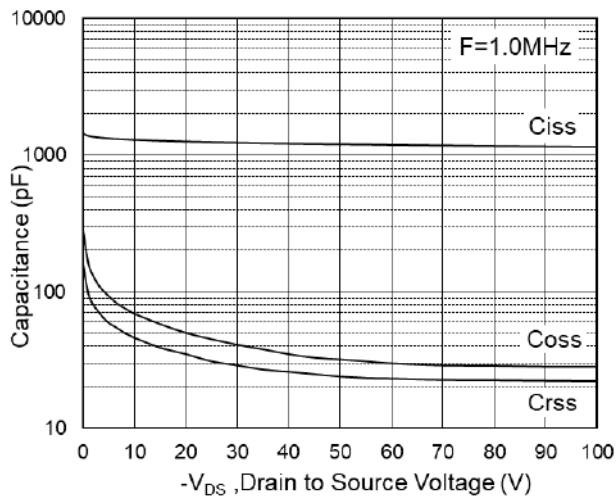


Fig.7 Capacitance

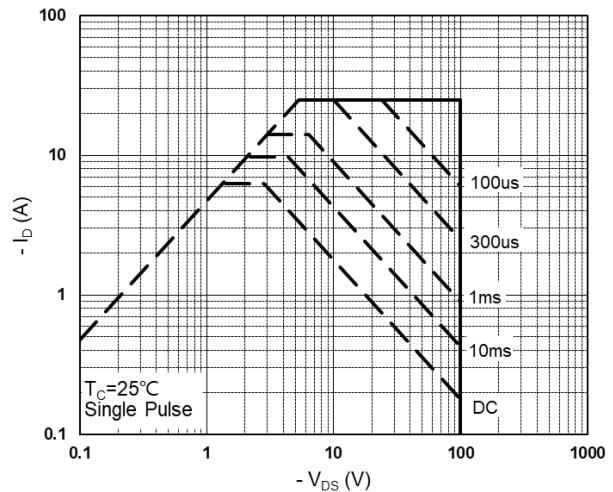


Fig.8 Safe Operating Area

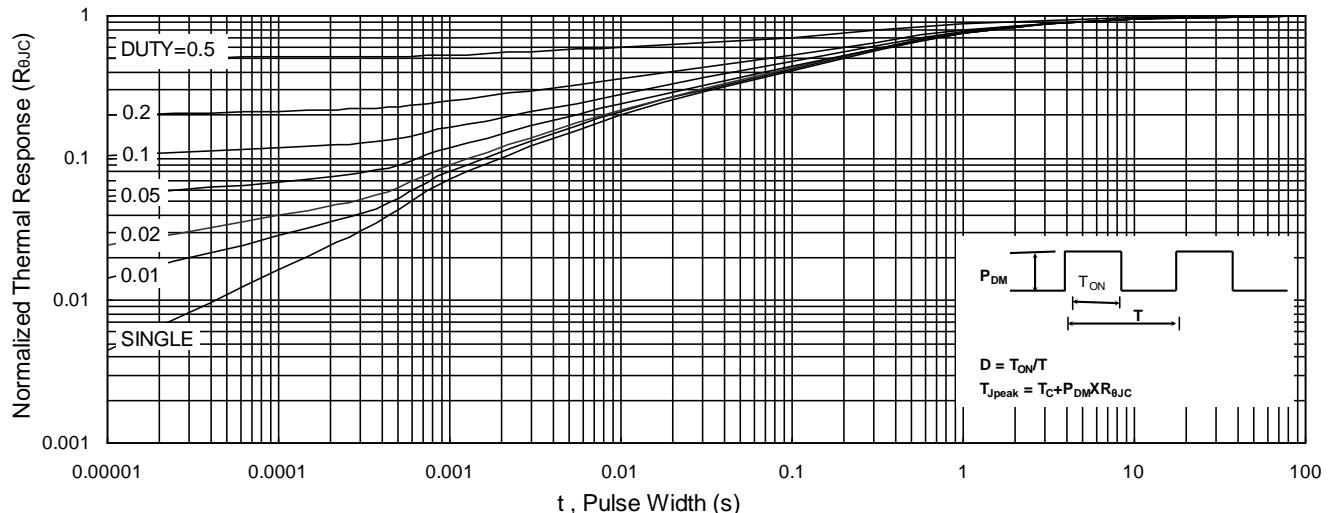


Fig.9 Normalized Maximum Transient Thermal Impedance

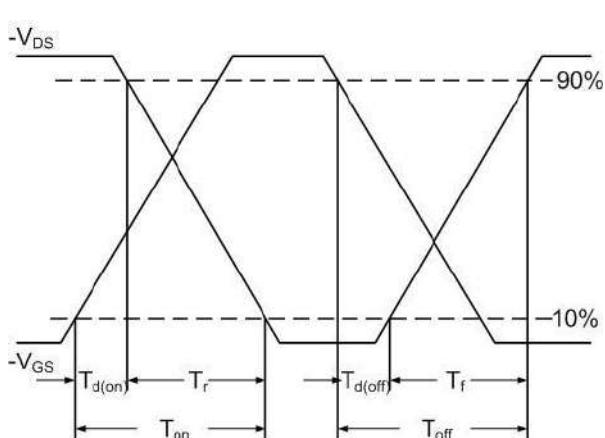


Fig.10 Switching Time Waveform

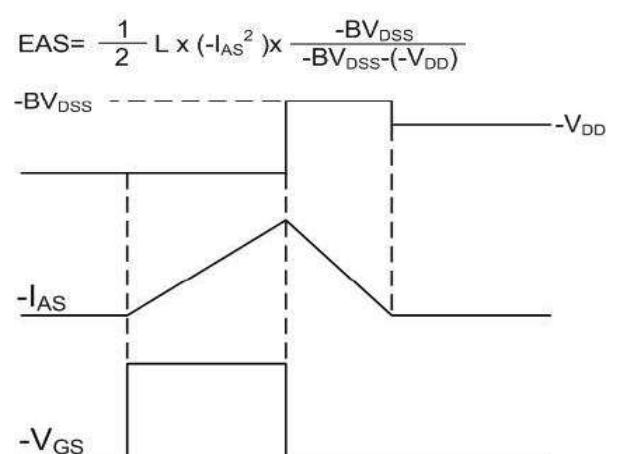


Fig.11 Unclamped Inductive Waveform